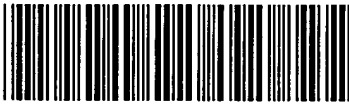


**Search Notes**

Application/Control No.

10/603,937

Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

MIYAGAWA, ICHIROU

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	241-244, 256-258	2/10/2006	HP
359	618, 639	2/10/2006	HP
	640		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	2/10/2006	HP